

Probes F20H / FW20 / D-F-ro

Data Sheet



Probe models

F20H

FW20

D-F-ro

Part no.¹

604-535

605-534

1006895

Measurement task

Coating thickness on steel, iron, cast iron base material (NC or NF/FE); NC/FE and NF/FE

Applications

Measuring the thickness of electrically non-conductive as well as of non-ferromagnetic metallic coatings on steel or iron base material (NC/FE and NF/FE).

Examples

- Paint, varnish, vulcanized rubber or plastic on iron, steel or cast iron (FE)
- Zinc, chromium or copper on iron or steel (FE)

Features

- Excellently suited for measurements on rough surfaces, measurements on smooth surfaces are of course also possible
- Wear resistant probe pole extends the operational readiness of the probe
- Humidity protection
- Angle probe FW20H with its small height is designed for measurements in pipes, bore holes and recesses
- Probe model F20H also available as digital probe (D-F-ro), in which the measurement signal is already converted into the measured value directly in the probe

Restrictions

- Less suitable for measurements on convex curved surfaces

*

The values for measurement range, trueness, repeatability precision and measurement deviations are valid for electrically non-conductive coating materials on steel or iron (NC/FE). The values may differ for measurements on non-ferromagnetic coating materials (NF).

The specifications for trueness and repeatability precision apply to ambient and specimen temperatures at the time of calibration. The values for trueness and repeatability may increase compared to the values specified here if the temperature during measurement differs from the temperature during calibration.

Measuring range*

0 ... 2500 µm (0 ... 98.43 mils)

Trueness*

Steel or iron base material (FE)

based on Fischer factory calibration standards at 20 °C (68 °F) for specimen and ambient temperature

0 ... 100 µm: ≤ 1.5 µm

(0 ... 3.94 mils: ≤ 0.06 mils)

100 ... 1000 µm: ≤ 1.5 % of nominal value

(3.94 ... 39.37 mils: ≤ 1.5 % of nominal value)

1000 ... 2500 µm: ≤ 3 % of nominal value

(39.37 ... 98.43 mils: ≤ 3 % of nominal value)

Repeatability precision*

Steel or iron base material (FE)

based on Fischer factory calibration standards at 20 °C (68 °F) for specimen and ambient temperature

0 ... 100 µm: ≤ 0.3 µm

(0 ... 3.94 mils: ≤ 0.012 mils)

100 ... 2500 µm: ≤ 0.3 % of reading

(3.94 ... 98.43 mils: ≤ 0.3 % of reading)

Influence*

Steel or iron base material (FE)

The following values are valid for a coating thickness with a nominal value of 75 µm (2.95 mils).

The quantity of influences are stated with the expanded measurement uncertainty U with the expanded factor of k = 2 (defines an interval with the confidence level of 95.45 %) – according to ISO/IEC Guide 98-3:2008-09 "Guide to the expression of uncertainty in measurement".

Curvature (R), measurement deviation from nominal value with reference to a calibration on flat surface

Measuring spot



No influence within the scope of trueness from R = 80 mm ± 6 mm (R = 3.15 " ± 0.24 ")

Measurement deviation of 10 % for R = 31 mm ± 1 mm (R = 1.2 " ± 0.039 ")

F20H and FW20H probes require a minimum of R = 25 mm (support stand necessary) (R = 0.98 ")

D-F-ro probe requires a minimum of R = 29 mm (support stand necessary) (R = 1.14 ")

Probes F20H / FW20 / D-F-ro

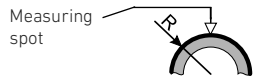
Influence*

Steel or iron base material (FE)

The following values are valid for a coating thickness with a nominal value of 75 µm (2.95 mils).

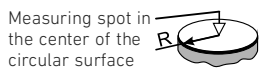
The quantity of influences are stated with the expanded measurement uncertainty U with the expanded factor of k = 2 (defines an interval with the confidence level of 95.45 %) – according to ISO/IEC Guide 98-3:2008-09 "Guide to the expression of uncertainty in measurement".

Curvature (R), measurement deviation from nominal value with reference to a calibration on flat surface



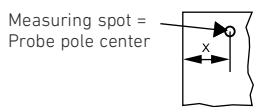
No influence within the scope of trueness from $R = 119 \text{ mm} \pm 5 \text{ mm}$ ($R = 4.69'' \pm 0.2''$)
 Measurement deviation of 10 % for $R = 24 \text{ mm} \pm 1 \text{ mm}$ ($R = 0.95'' \pm 0.039''$)
 Probe needs a minimum of $R = 1.5 \text{ mm}$ (support stand necessary) ($R = 0.06''$)

Edge distance (R), specification from probe tip center, measurement deviation from nominal value



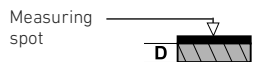
No influence within the scope of trueness from $R = 13.6 \text{ mm} \pm 0.3 \text{ mm}$ ($R = 0.54'' \pm 0.012''$)
 Measurement deviation of 10 % for $R = 6.8 \text{ mm} \pm 0.2 \text{ mm}$ ($R = 0.27'' \pm 0.0079''$)
 F20H and FW20H probes require a minimum of $R = 7 \text{ mm}$ (support stand necessary) ($R = 0.28''$)
 D-F-ro probe requires a minimum of $R = 8 \text{ mm}$ (support stand necessary) ($R = 0.32''$)

Edge distance (X), specification from probe tip center, measurement deviation from nominal value



No influence within the scope of trueness from $X = 4.4 \text{ mm} \pm 0.3 \text{ mm}$ ($X = 0.17'' \pm 0.012''$)
 Measurement deviation of 10 % for $X = 1.4 \text{ mm} \pm 0.12 \text{ mm}$ ($X = 0.055'' \pm 0.0047''$)

Base material thickness (D), measurement deviation from nominal value



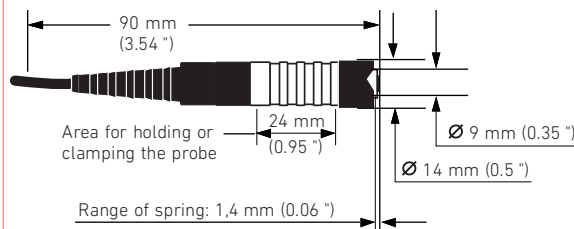
No influence within the scope of trueness from $D = 1.1 \text{ mm} \pm 0.12 \text{ mm}$ ($D = 0.043'' \pm 0.0047''$)
 Measurement deviation of 10 % for $D = 0.6 \text{ mm} \pm 0.03 \text{ mm}$ ($D = 0.024'' \pm 0.0012''$)

Base material

Influence on base material (FE) permeability in regard to Fischer calibration standards (master calibration): No influence within the scope of trueness from a ferrite content of 138.1 FN \pm 0.05 FN onwards.
 Measurement deviation of 10 % for ferrite content of 126 FN \pm 0.2 FN.

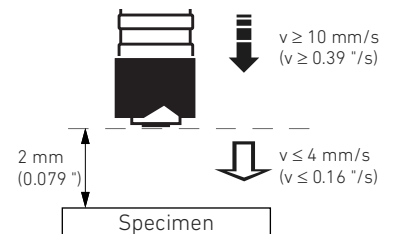
Probe design

Dimensions



Probe cable length: 1.5 m (59.06"), other cable lengths on request¹
 Bending radius: $\geq 30 \text{ mm}$ (1.18")

Approach and touchdown speed for automated measurement



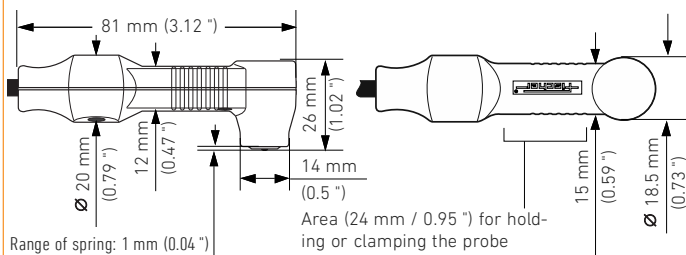
Lift-off distance between 2 measurements $\geq 10 \text{ mm}$ ($\geq 0.32''$)

F20H probe

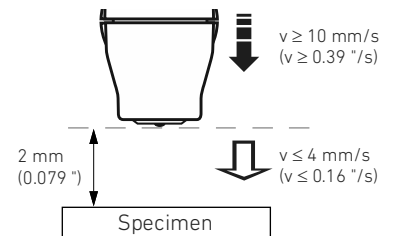
- Single pole axial probes with spring-loaded measuring system
- Humidity protection
- Probe pole tip
 - Wear-resistant
 - material: hard metal
 - radius: 2 mm (0.079")
 - Not replaceable

FW20 probe

- Single pole angle probe with spring-loaded measuring system
- Humidity protection
- Probe pole tip
 - Wear-resistant
 - material: hard metal
 - radius: 2 mm (0.079")
 - Not replaceable

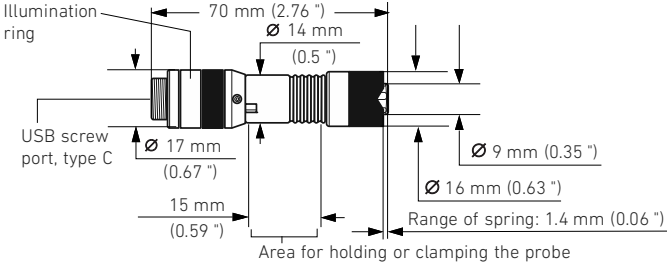
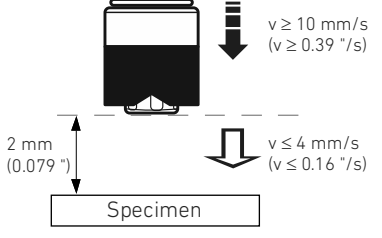


Probe cable length: 1.5 m (59.06"), other cable lengths on request¹
 Bending radius: $\geq 30 \text{ mm}$ (1.18")



Lift-off distance between 2 measurements $\geq 10 \text{ mm}$ ($\geq 0.32''$)

Probes F20H / FW20 / D-F-ro

Probe design	Dimensions	Approach and touchdown speed for automated measurement
D-F-ro probe <ul style="list-style-type: none"> Single pole axial probes with spring-loaded measuring system Humidity protection Probe pole tip <ul style="list-style-type: none"> Wear-resistant material: hard metal radius: 2 mm (0.079 ") Not replaceable 	 <p>Probe cable length: 1.5 m (59.06 "), other cable lengths on request¹ Bending radius: ≥ 30 mm (1.18 ")</p>	 <p>Lift-off distance between 2 measurements ≥ 10 mm (≥ 0.32 ")</p>
Admissible ambient temperature at operation	-10 °C ... +40 °C (+14 °F ... +104 °F)	
Admissible specimen temperature	max. +40 °C (+104 °F)	
Measuring method	Magnetic induction test method according to ISO 2178, ASTM D7091	
Calibration – Calibration foils	Lower measurement range (0 ... 800 µm (0 ... 31.5 mils))	Upper measurement range (800 ... 2500 µm (31.5 ... 98.43 mils))
<i>The specifications for trueness and repeatability precision only apply to a very narrow coating thickness range around the specified foil thickness for a 1-point calibration and for a 2-point calibration only for the coating thickness range limited by the thicknesses of the two calibration foils.</i>		
Use following foil thickness (pairings) for calibration	1-point calibration: 1 foil up to ca. 800 µm (31.5 mils) 2-point calibration: 2 foils up to ca. 800 µm (31.5 mils)	1-point calibration: not recommended 2-point calibration: foil 1 ca. 800 µm (31.5 mils); foil 2 ca. 2000 µm (78.74 mils)
Probes work with	<ul style="list-style-type: none"> Hand-held instruments: all DUALSCOPE® and DELTASCOPE® instruments of the FMP series F20H: all DUALSCOPE® and DELTASCOPE® instruments of the DMP® series by using DMP®-F-Probe-Adapter (1007336) Bench top instruments: FISCHERSCOPE® MMS® PC and FISCHERSCOPE® MMS® PC2 both with PERMASCOPE® F-Probe module (604-293, 12-pin connecting socket) 	
F20H and FW20H (analog probes)		
D-F-ro (digital probe)	<ul style="list-style-type: none"> Hand-held instruments: all DUALSCOPE® and DELTASCOPE® instruments of the DMP® series 	
Scope of delivery	<ul style="list-style-type: none"> All: Probe with connecting cable, calibration foil set 605-414 (metal plate NF/FE for instrument check, 2 calibration foils with thicknesses of approx. 13 µm (0.51 mils) (CuBe) and 250 µm (9.84 mils)) F20H, additional: prism adapter for measurements on pipes and bars D-F-ro: probe connecting cable with screwable USB C plugs 	
Options	<ul style="list-style-type: none"> Calibration foils: Various foil thickness are available up to 2000 µm (78.7 mils); suitable calibration foil thicknesses are specified in section Calibration – Calibration foils Manufacturer Certificate M according to DIN 55350-18 (only in connection with measuring instrument) Support stand V12 BASE, 604-420, with mechanical probe lowering device; F20H: suitable probe clamp 602-370 included in support stand delivery D-F-ro: suitable probe clamp 600-213; FW20H: no probe clamp available Support stand V12 MOT, 604-374, with motorized probe lowering device for highest repeatability; F20H: suitable probe clamp 602-370 included in support stand delivery D-F-ro: suitable probe clamp 600-213; FW20H: no probe clamp available 	

¹ Probes with special cable lengths have own part no. and probe model names. This data sheet also applies to these probes.
Probe D-F-ro: max. cable length 3 m (118 "), it is not allowed to use a USB extension cable to connect probe to instrument!

Probes F20H / FW20 / D-F-ro

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